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Form PTO-1449				Atty Docket No. SUN040025		Serial No. 10/672,836	
INFORMATION DISCLOSURE CITATION IN AN APPLICATION <i>(Use several sheets if necessary)</i>				Applicant(s) Eduard K. de Jong			
				Filing Date September 25, 2003		Group 2193	

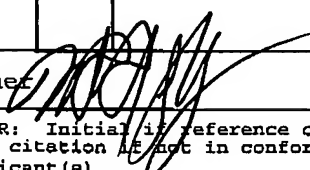
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
TE	AA	4,434,436	02/28/84	Kleykamp et al.	380	209	
	AB	5,913,064	06/15/99	Chen	717	108	
	AC	6,006,328	12/21/99	Drake	726	23	
	AD	6,098,056	08/01/00	Rusnak et al.	705	75	
	AE	6,101,606	08/08/00	Diersch et al.	726	27	
	AF	6,175,925	01/16/01	Nardone et al.	726	22	
	AG	6,178,509	01/23/01	Nardone et al.	726	22	
	AH	6,205,550	03/20/01	Nardone et al.	726	22	
	AI	6,266,416	07/24/01	Sigbjørnsen et al.	380	255	
	AJ	6,308,256	10/23/01	Folmsbee	712	209	
	AK	6,334,189	12/25/01	Granger et al.	726	26	
	AL	6,449,721	09/10/02	Pensak et al.	713	171	
	AM	6,480,959	11/12/02	Granger et al.	713	189	
	AN	6,643,775	11/04/03	Granger et al.	713	190	
	AO	6,694,435	02/17/04	Kiddy	713	189	
	AP	6,966,002	11/15/05	Torrubia-Saez	726	29	
	AQ	6,981,217	12/27/05	Knauff et al.	715	531	
	AR	7,017,188	03/21/06	Schmeidler et al.	726	26	
AS	7,054,443	05/30/06	Jakubowski et al.	380	28		
AT	7,065,652	06/20/06	Xu et al.	713	190		

FOREIGN PATENT DOCUMENTS							
	DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation	
						YES	NO
TE	AU	WO 00/75760	12/14/00	PCT			

OTHER DOCUMENTS (including Author, Title, Date, Pertinent Pages, Etc.)	
TE	AV Mambo et al., "A Tentative Approach to Constructing Tamper-Resistant Software", ACM 1998, pages 23-33.
Examiner	Date Considered 5/31/07

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant(s).

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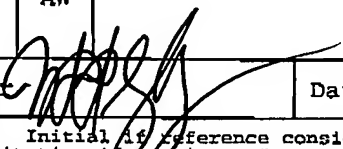
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U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE	
TF	AA	7,080,039	07/18/06	Marsh	705	51		
	AB	7,124,445	10/17/06	Cronce et al.	726	26		
	AC	2002/0184618	12/05/02	Bala et al.	717	148		
	AD	2003/0093685	05/15/03	Tobin	713	190		
	AE	2003/0123664	07/03/03	Pedlow et al.	380	218		
	AF	2003/0172270	09/11/03	Newcombe et al.	713	168		
	AG	2003/0177391	09/18/03	Ofeek et al.	726	4		
	AH	2003/0188187	10/02/03	Uchida	726	26		
	AI	2003/0191938	10/09/03	Woods et al.	713	165		
	AJ	2003/0233542	12/18/03	Benaloh	713	156		
	AK	2004/0003264	01/01/04	Zeman et al.	713	190		
	AL	2004/0003278	01/01/04	Chen et al.	726	21		
	AM	2004/0039932	02/26/04	Elazar et al.	726	26		
	AN	2004/0103404	05/27/04	Naumovich et al.	717	136		
	AO	2004/0151306	08/05/04	Kiddy	380	28		
	AP	2004/0260933	12/23/04	Lee	713	193		
	AQ	2005/0002053	01/06/05	Meador et al.	358	1.14		
	AR	2005/0015454	01/20/05	Goodman et al.	709	207		
	AS	2005/0021995	01/27/05	Lal et al.	726	4		
	TF	AT	2005/0044359	02/24/05	Eriksson et al.	713	165	
FOREIGN PATENT DOCUMENTS								
							Translation	
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	YES	NO
TF	AU	WO 01/79972	10/25/01	PCT				
OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)								
	AV							
Examiner 				Date Considered 5/31/07				
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U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
TF	AA	2005/0055564	03/10/05	Haselden et al.	726	26	
	AB	2005/0102264	05/12/05	Nason et al.	707	1	
	AC	2006/0026430	02/02/06	Luo	713	176	
	AD	2006/0048228	03/02/06	Takemori et al.	726	22	
	AE	2006/0218539	09/28/06	Stiemens et al.	717	140	
TH	AF	2006/0271921	11/30/06	Cronce et al.	717	151	
	AG						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	Translation YES NO
TF TH	AU	WO 02/079955	10/10/02	PCT			
	AV	WO 04/027678	04/01/04	PCT			

OTHER DOCUMENTS (Including Author, Title, Date, Pertinent Pages, Etc.)	
AW	
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